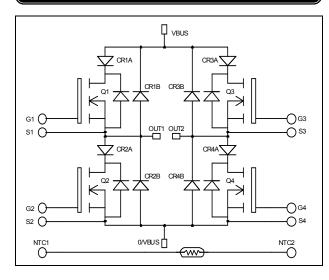


Full – Bridge Series & SiC parallel diodes Super Junction MOSFET Power Module



G4 🛭

S4 🛭

S2 () G2 ()

O/VBUS

OUT2

OUT1

NTC1 (

$$\begin{split} V_{DSS} &= 800 V \\ R_{DSon} &= 290 m\Omega \ max \ @ \ Tj = 25^{\circ}C \\ I_D &= 15A \ @ \ Tc = 25^{\circ}C \end{split}$$

Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

- CoolMOSTM
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated

• Parallel SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25$ °C unless otherwise specified

Absolute maximum ratings

0 G3

0 S3

0

VBUS

| Symbol | Parameter | | Max ratings | Unit |
|--------------|---|---------------------|-------------|-----------|
| $V_{ m DSS}$ | Drain - Source Breakdown Voltage | | 800 | V |
| Ţ | ('ontinuous I)rain ('urrent | $T_c = 25$ °C | 15 | |
| I_{D} | | $T_c = 80$ °C | 11 | A |
| I_{DM} | Pulsed Drain current | 60 | | |
| V_{GS} | Gate - Source Voltage | | ±30 | V |
| R_{DSon} | Drain - Source ON Resistance | | 290 | $m\Omega$ |
| P_{D} | Maximum Power Dissipation | $T_c = 25^{\circ}C$ | 156 | W |
| I_{AR} | Avalanche current (repetitive and non repetitive) | | 17 | A |
| E_{AR} | Repetitive Avalanche Energy | | 0.5 | Т |
| E_{AS} | Single Pulse Avalanche Energy | | 670 | mJ |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

APTC80H29SCTG-Rev 4 October, 2013



Electrical Characteristics

| Symbol | Characteristic | Test Conditions | Min | Тур | Max | Unit |
|---------------------|---------------------------------|---|-----|-----|------|------|
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{GS} = 0V, V_{DS} = 800V$ $T_j = 25^{\circ}C$ | | | 25 | 4 |
| | | $V_{GS} = 0V, V_{DS} = 800V$ $T_j = 125^{\circ}C$ | | | 250 | μΑ |
| R _{DS(on)} | Drain – Source on Resistance | $V_{GS} = 10V, I_D = 7.5A$ | | | 290 | mΩ |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 1 \text{mA}$ | | 3 | 3.9 | V |
| I_{GSS} | Gate – Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

Dynamic Characteristics

| Symbol | Characteristic | Test Conditions | Min | Тур | Max | Unit |
|-------------------|-------------------------------------|---|-----|------|-----|------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ | | 2254 | | |
| C_{oss} | Output Capacitance | $V_{\rm DS} = 25V$ | | 1046 | | pF |
| C_{rss} | Reverse Transfer Capacitance | f = 1MHz | | 54 | | |
| Q_{g} | Total gate Charge | $V_{GS} = 10V$ | | 91 | | |
| Q_{gs} | Gate – Source Charge | $V_{\text{Bus}} = 400 \text{V}$ | | 12 | | nC |
| Q_{gd} | Gate – Drain Charge | $I_D = 15A$ | | 46 | | |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive switching @125°C $V_{GS} = 15V$ $V_{Bus} = 533V$ $I_D = 15A$ | | 10 | | |
| T_{r} | Rise Time | | | 13 | | ns |
| $T_{d(off)}$ | Turn-off Delay Time | | | 83 | | |
| T_{f} | Fall Time | $R_G = 5\Omega$ | | 35 | | |
| Eon | Turn-on Switching Energy | Inductive switching @ 25°C | | 146 | | T |
| E_{off} | Turn-off Switching Energy | $V_{GS} = 15V, V_{Bus} = 533V$ $I_D = 15A, R_G = 5\Omega$ | | 139 | | μJ |
| Eon | Turn-on Switching Energy | Inductive switching @ 125°C $V_{GS} = 15V$, $V_{Bus} = 533V$ $I_D = 15A$, $R_G = 5\Omega$ | | 255 | | т |
| E_{off} | Turn-off Switching Energy | | | 171 | | μJ |
| R_{thJC} | Junction to Case Thermal Resistance | | | | 0.8 | °C/W |

Series diode ratings and characteristics

| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|-------------------|---|----------------------|----------------------------------|------|------|-----|------|
| V_{RRM} | Maximum Peak Repetitive Reverse Voltage | | | 1000 | | | V |
| I_{RM} | Maximum Reverse Leakage Current | $V_{R}=1000V$ | | | | 250 | μA |
| I_F | DC Forward Current | | $Tc = 85^{\circ}C$ | | 30 | | A |
| | Diode Forward Voltage | $I_F = 30A$ | | | 1.9 | 2.3 | |
| V_{F} | | $I_F = 60A$ | | | 2.2 | | V |
| | | $I_F = 30A$ | $T_j = 125$ °C | | 1.7 | | |
| 4 | Reverse Recovery Time | 1 - 204 | $T_j = 25$ °C | | 290 | | nc |
| t_{rr} | | | $T_{j} = 125^{\circ}C$ | | 390 | | ns |
| Q _{rr} | Reverse Recovery Charge | $di/dt = 200A/\mu s$ | $T_j = 25$ °C | | 670 | | пC |
| | | | $T_{\rm j} = 125^{\circ}{\rm C}$ | | 2350 | | IIC. |
| R_{thJC} | Junction to Case Thermal Resistance | | | | | 1.2 | °C/W |



Parallel diode ratings and characteristics

| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|-------------|--|---|--|------|------------|-------------|------|
| V_{RRM} | Maximum Peak Repetitive Reverse Volt | age | | 1200 | | | V |
| I_{RM} | Maximum Reverse Leakage Current | V _R =1200V | $T_{j} = 25^{\circ}C$ $T_{j} = 150^{\circ}C$ | | | 200 1000 | μΑ |
| I_F | DC Forward Current | | Tc = 125°C | | 10 | | A |
| $V_{\rm F}$ | Diode Forward Voltage | $I_F = 10A$ | $T_i = 25^{\circ}C$ $T_j = 150^{\circ}C$ | | 1.5 2.1 | 1.8 | V |
| $Q_{\rm C}$ | Total Capacitive Charge | $I_F = 10A, V_R = 800V$ di/dt = $100A/\mu s$ | | | 30 | | nC |
| Q | T . I G | $f = 1MHz, V_R =$ | = 200V | | 71 | | |
| | Total Capacitance $f = 1MHz, V_R = 400V$ | | = 400V | | 52 | | pF |
| R_{thJC} | Junction to Case Thermal Resistance | | | | 2.7 | °C/W | |

Thermal and package characteristics

| Symbol | Characteristic | | | Min | Max | Unit |
|-------------|--|-------------|----|------|------------------------|------|
| V_{ISOL} | RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz | | | 4000 | | V |
| T_{J} | Operating junction temperature range | | | -40 | 150 | |
| T_{JOP} | Recommended junction temperature under switching conditions | | | -40 | T _J max -25 | °C |
| T_{STG} | Storage Temperature Range | | | -40 | 125 | |
| $T_{\rm C}$ | Operating Case Temperature | | | -40 | 100 | |
| Torque | Mounting torque | To Heatsink | M5 | 2.5 | 4.7 | N.m |
| Wt | Package Weight | | | | 160 | g |

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

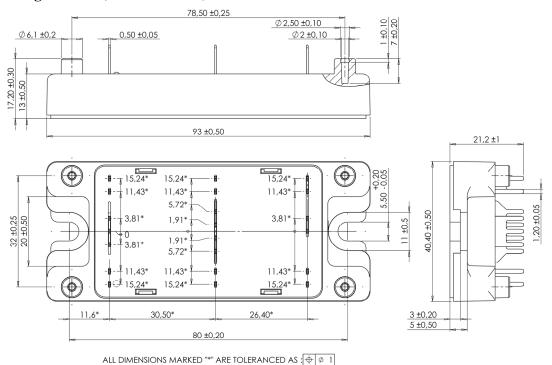
| 1 chip of actual of Selfson 1 v 1 c (see approach in the rin 10 100 on www.interesemi.com for more information). | | | | | | | |
|--|-----------------------------|----------------------------------|-----|------|-----|------|--|
| Symbol | Characteristic | | Min | Typ | Max | Unit | |
| R ₂₅ | Resistance @ 25°C | | | 50 | | kΩ | |
| $\Delta R_{25}/R_{25}$ | | | | 5 | | % | |
| $B_{25/85}$ | $T_{25} = 298.15 \text{ K}$ | | | 3952 | | K | |
| $\Delta B/B$ | | $T_{\rm C} = 100^{\circ}{\rm C}$ | | 4 | | % | |

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_T: \text{ Thermistor value at T}$$



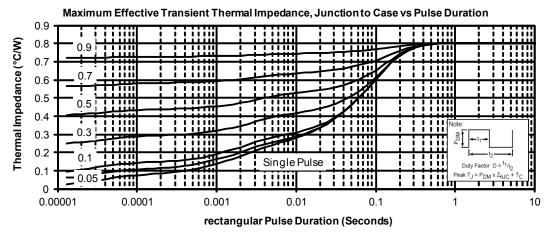
SP4 Package outline (dimensions in mm)

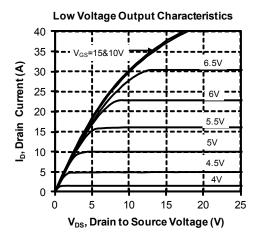


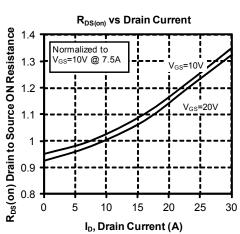
 $See \ application \ note \ APT0501 - Mounting \ Instructions \ for \ SP4 \ Power \ Modules \ on \ www.microsemi.com$

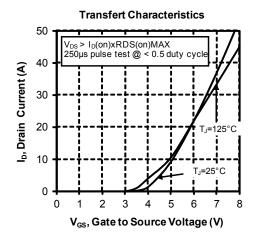


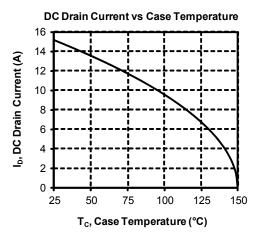
Typical CoolMOS Performance Curve



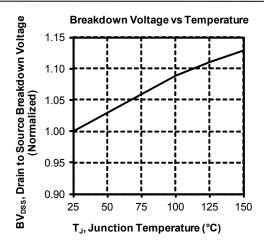


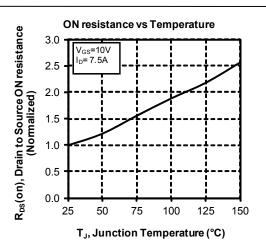


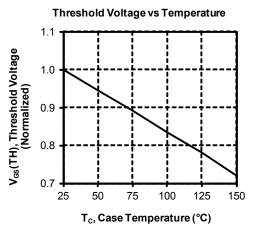


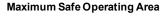


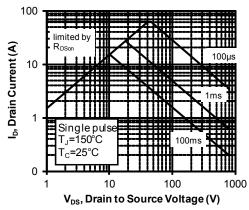


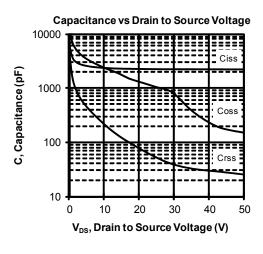


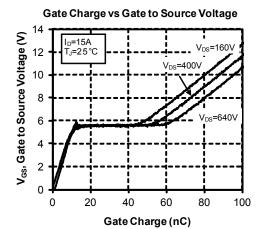




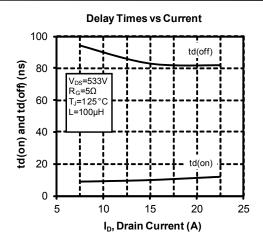


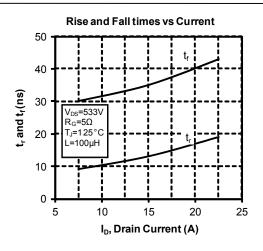


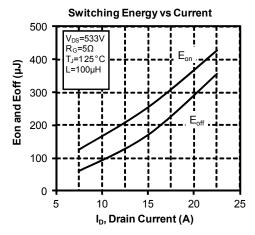


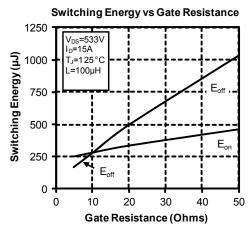


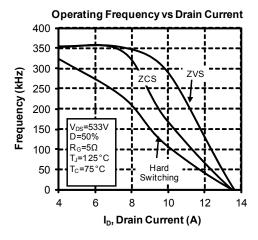






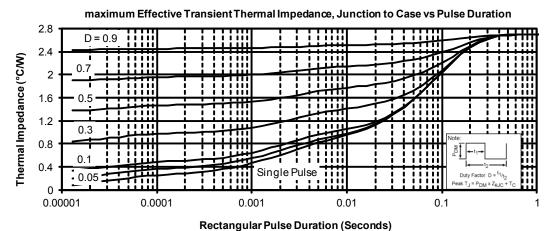


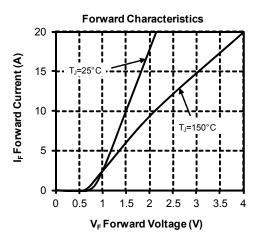


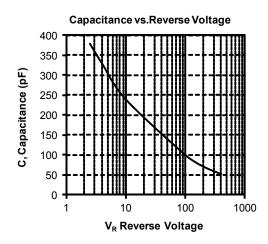




Typical SiC Diode Performance Curve







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